

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10599208	DELAHAYE, FRANCK
	<b>Examiner</b>	<b>Art Unit</b>
	Kin-Chan Chen	1792

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
438	745, 747, 750, 753,	2/24/2009	KCC
216	83, 84	2/24/2009	KCC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST KEY WORD SEARCH, USPAT, USPG_PUB, EPO, JPO, DERWENT, IBM_TBD, INVENTOR SEARCH	2/24/2009	KCC
Updated above search	6/9/2010	MA

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/MAKI A ANGADI/  
Examiner.Art Unit 1713